

Record 1 of 1

Title: DeepGauge: Multi-Granularity Testing Criteria for Deep Learning Systems

Author(s): Ma, L (Ma, Lei); Juefei-Xu, F (Juefei-Xu, Felix); Zhang, FY (Zhang, Fuyuan); Sun, JY (Sun, Jiyuan); Xue, MH (Xue, Minhui); Li, B (Li, Bo); Chen, CY (Chen, Chunyang); Su, T (Su, Ting); Li, L (Li, Li); Liu, Y (Liu, Yang); Zhao, JJ (Zhao, Jianjun); Wang, YD (Wang, Yadong)

Edited by: Huchard M; Kastner C; Fraser G

Source: PROCEEDINGS OF THE 2018 33RD IEEE/ACM INTERNATIONAL CONFERENCE ON AUTOMTED SOFTWARE ENGINEERING (ASE' 18) **Book Series:** IEEE ACM International Conference on Automated Software Engineering **Pages:** 120-131 **DOI:** 10.1145/3238147.3238202 **Published:** 2018

Accession Number: WOS:000553784500015

Conference Title: 33rd IEEE/ACM International Conference on Automated Software Engineering (ASE)

Conference Date: SEP 03-07, 2018

Conference Location: Montpellier, FRANCE

Conference Sponsors: IEEE, Assoc Comp Machinery, ACM SIGSOFT, ACM SIGAI, CNRS, IEEE CS, Huawei, Berger Levrault, Mobioos, Toyota InfoTechnol Ctr, Reg Occitanie, Inria, LIRMM, Univ Montpellier, Inst Mines Telecom Ecole Mines Telecom, Montpellier Univ Excellence, Investissements DAvenir

Author Identifiers:

Author	Web of Science ResearcherID	ORCID Number
Liu, Yang	D-2306-2013	0000-0001-7300-9215
Xue, Minhui		0000-0002-9172-4252
Chen, Chunyang		0000-0003-2011-9618

ISSN: 1527-1366

ISBN: 978-1-4503-5937-5